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Research Article

Parametric Investigation of Particle Movements in Ultrasonic Levitation Process Using Piezoelectric Materials

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ABSTRACT

Using ultrasonic waves to levitate particles is ultrasonic levitation, and it has potential applications in various fields such as micromaterial handling, medicine, and material characterization. For many of these applications, the behavior of the levitated particles during the levitation time is critical, including movements of the particle at a levitated point. Electrical potential and the distance between the transducer and reflector are two main parameters affecting the movement of the levitated particles. In this paper, a second-order linear model considering the effect of these parameters was presented to predict particle movement based on numerical results. In the modeling part, a 2D COMSOL dimensional axis-symmetric finite element model has been used to simulate ultrasonic levitation. Experimental tests have been performed and used to validate the model. The results in this report could help to understand the main factors in the movement of the levitated particle and develop methodologies for particle stabilization.

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1. Introduction

Ultrasonic levitation is a process of using ultrasonic waves to levitate particles. The levitation system consists of an ultrasonic transducer and a reflector. An ultrasonic transducer can be used instead of a reflector. If the distance between the piezoelectric transducer and reflector is properly adjusted, the superposition of the original and the reflected waves will create static low-pressure and high-pressure regions, which are alluded to as node and anti-node. The interference between waves generated from the piezoelectric transducer and

the reflected wave from the reflector (or generated from the other transducer) will create a standing wave which can levitate a particle.

In addition to the ultrasound levitation mechanism, there are other methods such as magnetic[1], electromagnetic[2], superconductor [3], and optical levitation[4]. Particle levitation has been used in the pharmacy[5], medicine[6], Chemistry[7], Physics[8] and engineering[9] applications. The main limitation of non-ultrasound levitation methods is that the levitation depends on the physical properties and

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geometry of the particles. Therefore, ultrasonic levitation is independent of the material property and shape, which makes it more applicable to a wider range of applications. Additionally, ultrasonic levitation provides non-contact movement of particles, which makes it suitable for microassembly.

Within the literature on particle levitation, Gor'kov [10] presented analytical modeling of spherical particle force in the ultrasonic levitation field. It was shown that the viscosity of the acoustic levitation medium and the thermal condition are the main factors in ultrasonic levitation when the particle size is small enough compared with the wavelength. Xie and Wei [11] studied single-axis ultrasonic levitation and enhanced the capability of this method by using the curving surface reflector. Kozuka et al. [12] developed an acoustical particle manipulation method based on phase change of acoustic waves. Henrik Bruus [13] reviewed the fundamentals of the ultrasound acoustophoresis phenomena and the propagation of waves. Zhao and Wallaschek [14] presented a method to levitate a large planner object. The levitated disc also played a reflector role in this method. Baer et al. [15] used a concave shape for the radiating surface and reflector and improved the stabilization of the levitated particle due to it. A stabilization analysis of the new and conventional designs of the ultrasonic levitating device was also conducted. However, there is no discussion about the effect of levitating parameters, such as input voltage, on particle stability. Andrade et al. [16] used a symmetrical array with three ultrasonic transducers to levitate a solid sphere that was 3.6 times larger than the wavelength. Li et al. [17] improved the load capability of near field zone in ultrasonic levitation by adding a groove on the reflector surface. Keremer et al. [8] presented a new method for measuring the viscosity of a fluid under high pressure using ultrasonic levitation. This method resulted in a shorter measurement time compared to the conventional methods. Andrade et al. [18] demonstrated that levitation particle movement can be controlled by changing the distance between the reflector and the transducer at a constant frequency. Andrade et al. [19] showed the effect of drop shape on the resonance behavior of the device and droplet stability. Hasegawa and Murata [20] not only illustrated that levitated droplets exhibit the lowest displacement amplitude at the third pressure node but also reported that the oscillation of droplets in the acoustic field in the vertical direction is considerably smaller than that in the horizontal direction. Argyris et al. [21] noticed that the deformation of an acoustically levitated droplet is influenced by its surface

tension. So, they suggested a machine learning algorithm that can obtain the surface tension based on droplet dynamics analysis. Cancino-Jaque et al. [22] maximize the droplet diameter (6.82 mm) that can be levitated in an ultrasonic field by setting the range for the maximum sound pressure level and optimizing the levitation conditions.

The levitated particle stability is an essential subject in many applications of ultrasonic levitation. Particularly, the estimation of particle behavior in the transient region has a strong potential in the applications of ultrasonic levitation in material recognition and evaluation. According to the literature, there is no comprehensive information about this topic. In this paper, a second-order parametric model is presented based on the numerical study to study the effect of input voltage and distance between the transducer and the reflector on the movement of levitated particles. The benefit of this model is ease of use in different applications of evaluating and controlling particles. COMSOL Multiphysics software was used for the numerical simulation. The numerical study consists of the piezoelectric, acoustic, modal, harmonic, and particle tracing physics in COMSOL. Numerical results were validated with the experiments. The contribution of this study is to present a comprehensive model that considers the input voltages and the distance between the transducer and reflector.

2. Ultrasonic Levitation Background

In the theoretical part, the forces involved in the ultrasonic levitation process are gravity w , ultrasonic force F_a , drag force F_d , and buoyancy force F_b . For a spherical particle, the gravity force is obtained from Eq(1) [10].

$$w = \frac{4\pi r^3 \rho g}{3} \quad (1)$$

where r and ρ are the radius and the density, respectively.

Acoustophoretic force from computational fluid dynamics is calculated from Gor'kov's formula Eq(2)[11]. This force is used for the case where particles are significantly smaller than the wavelength of the wave.

$$F_a = -\nabla U \quad (2)$$

where U is the radiation potential and it is obtained from Eq(3) [10].

$$U = 2\pi r^3 \left[\left(\frac{\overline{P_p^2}}{3\rho c^2} \right) f_1 - \left(\frac{\rho \overline{v_p^2}}{2} \right) f_2 \right] \quad (3)$$

where P_p is the pressure of the particle, v_p is the particle velocity, c is the ultrasound wave velocity in air, and f_1 and f_2 parameters are calculated from Eq(4) and Eq(5) [10].

$$f_1 = 1 - \frac{\rho c^2}{\rho_s c_s^2} \quad (4)$$

$$f_2 = \frac{2(\rho_s - \rho)}{(2\rho_s + \rho)} \quad (5)$$

where c and c_s are the sound speed in levitated medium and levitated particle respectively and ρ_s is the density of the levitated particle.

$$P_b = -\frac{\rho \partial \Phi_{in}}{\partial t} \quad (6)$$

$$v_p(l) = \frac{P_0}{Z_f} \sin(kl) \quad (7)$$

$$v_{in} = \nabla \Phi_{in} \quad (8)$$

where Φ_{in} is the velocity potential of the acoustic field.

The drag force F_d is the force that prevents the levitated object from moving in the fluid and it can be determined by Eq(9)[12].

$$F_d = \frac{m_p(u - v)}{\tau_p} \quad (9)$$

where m_p is particle mass, τ_p is particle response velocity, v is particle velocity and u denotes fluid velocity. For the Reynolds number less than 1, the particle response rate for spherical particles in the laminar flow is obtained from Eq (10) [12].

$$\tau_p = \frac{\rho_p d_p^2}{18\mu} \quad (10)$$

where μ is fluid viscosity, ρ_p is the particle density and d_p is the particle diameter.

The buoyancy force follows Archimedes' law and is considered whenever a body is submerged or floated in fluid. The buoyancy force is in the opposite direction of gravity, and it is independent of the shape of the levitated object. The buoyancy force in gases is small and hence could be neglected for the proposed case.

As was described in this section, different complicated forces play a role in the ultrasonic levitation process. So, it is challenging to model particle movement during this process analytically. The numerical method is a suitable alternative for this purpose.

3. Ultrasonic Levitator Design

In this section, the design of an ultrasonic levitator is described. The levitator is composed of a transducer, a reflector, and the support mechanical and electrical/electronic subsystems.

3.1. Transducer and Reflector Specifications

The design procedure and behavior study of a sonic Langevin transducer with magnetostrictive materials was described in [13-17], and the design procedure and behavior study of an ultrasonic transducer with piezoelectric materials was also investigated in [18, 19]. Following the same procedure, a Langevin transducer with a resonance frequency of 20kHz and 2kW nominal power was designed and fabricated. The transducer consists of four main parts, matching, piezoelectric rings, central screw, and backing, all of which have axial symmetry. Figure 1 shows the technical drawing and fabricated picture of the transducer.



Fig. 1. The fabricated transducer

In addition, a wave reflector, with the capability to adjust the distance between the transducer and reflector, was designed and fabricated using aluminum material, and the adjustment mechanism was a screw to change the distance. In addition, even though using a curved reflector could improve stabilization, using a flat reflector occupies less area and provides opportunities for more applications. Hence, a flat reflector was selected for this study.

3.2. Modeling and Numerical Analysis

COMSOL Multiphysics software was used in this study to analyze the levitation process and numerically investigate the behavior of the suspended sample. Because of COMSOL Multiphysics's ability to link several physics, multiphysics problems can be reliably simulated. In other words, in this software, similar to reality, applying a voltage to the piezoelectric changes the length, and length variation creates waves with the desired frequency. This process can be simulated in COMSOL Multiphysics software using solid mechanics, electrostatics, and sound pressure physics.

In the mentioned simulation, after drawing the symmetrical two-dimensional model of the levitation system (Fig. 2a) consisting of the transducer with a final cylindrical space with a 90 mm diameter and the reflector (a distance equal to half-wavelength coefficients from the transducer) just like Fig. 2b, by applying voltage in electrostatic physics, it is possible to obtain the size change of piezoelectric in solid mechanical physics. In the next step, the mentioned dimension changes cause force distribution in the levitation gap and create a standing wave with the help of acoustic pressure physics.

Finally, by coupling the particle tracing tracking physics, the desired number of particles with the desired properties can be placed in the levitation gap, and by adding gravity force, buoyancy force, and drag force, all the effective factors in the ultrasonic levitation can be investigated in the simulation. The change in the input voltage to the piezoelectrics causes a change in the generated wave and the behavior of the levitated particle.

In the meshing section, the element type was the free triangular element, and the mesh size was equal to 10% of the wavelength according to the mesh-independent study to avoid the effect of mesh size in the results (Fig. 2. c).

For the particle movement study, the simulations were repeated for voltage parameters of 200V,300V,400V,500V, and 700V, and distance parameters of ($\lambda/2$, λ , and $3\lambda/2$) and five levitated particles. A voltage of more than 700 V is less used in this process due to the complexity of production, safety conditions, and the lack of need for this amount in the levitation of particles. Distances longer than $3\lambda/2$ are rarely used due to wave attenuation. The particle movement along the symmetrical axis of the transducer (z-axis) was recorded for the one-second period and 0.05-second time intervals. The average displacements of the levitated particles were considered a measure of particle movement.

3.3. Experimental Study

The experimental setup (Fig. 2. b) was designed and fabricated to verify numerical results. This setup consisted of a resonance ultrasonic transducer, power supply, adjustable reflector, high-resolution camera, and calibration gauge. An image processing technique was used to measure particle movement. Image processing was calibrated using an accurate calibration gauge (Fig. 2. b). The tests were repeated thrice to increase reliability.

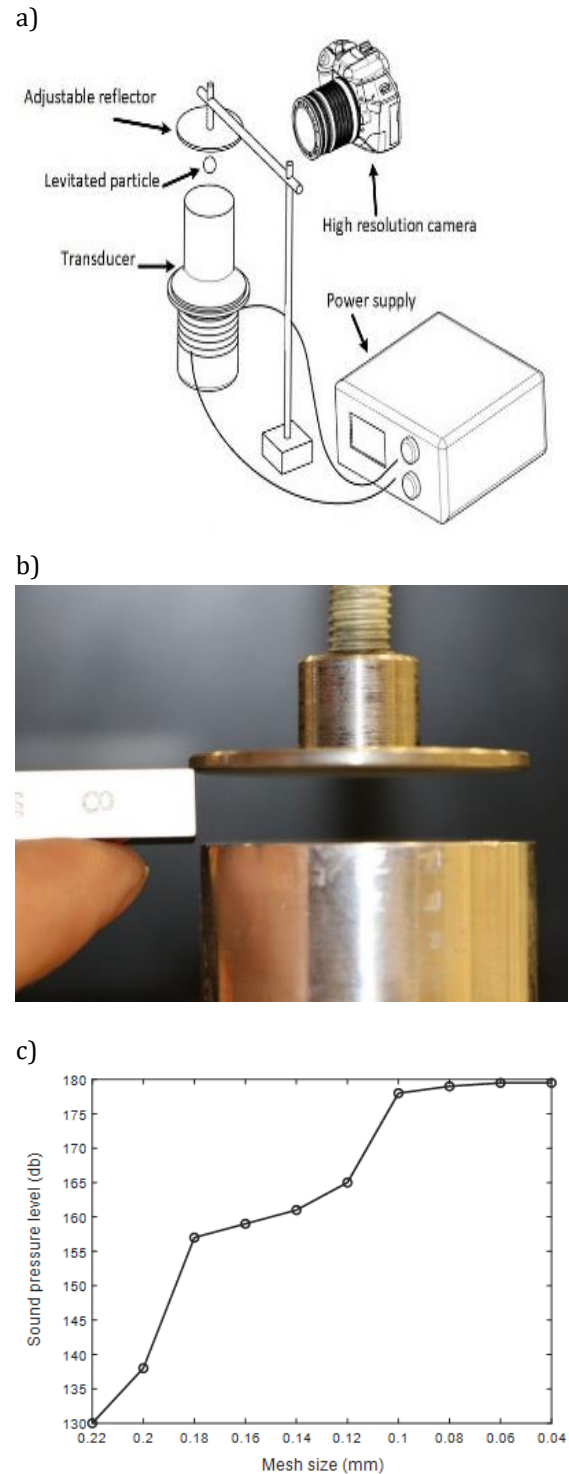


Fig. 2. (a) Schematic of the experimental Setup, (b) Calibration gauge, (c) Mesh independence analysis study for the choice of mesh size for FEM analysis

4. Simulation Validation

In the numerical study, to make the conditions uniform in repeating the simulations, the levitation acceptance condition was the levitation of at least one particle of 5 levitated particles. Figure 3 shows the numerical results of particle levitation.

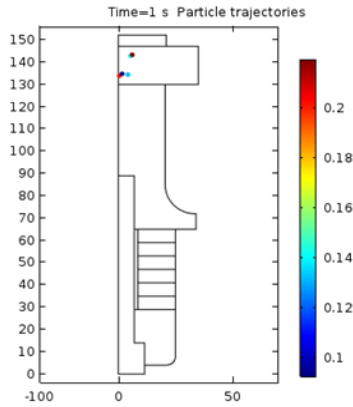
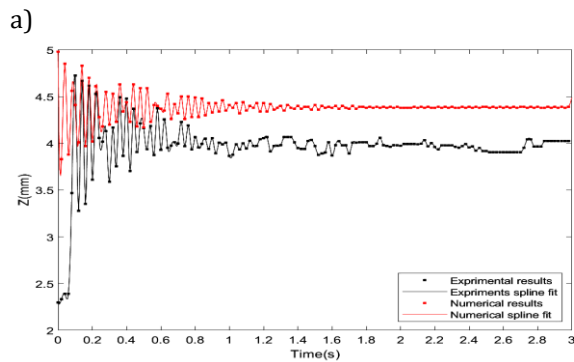


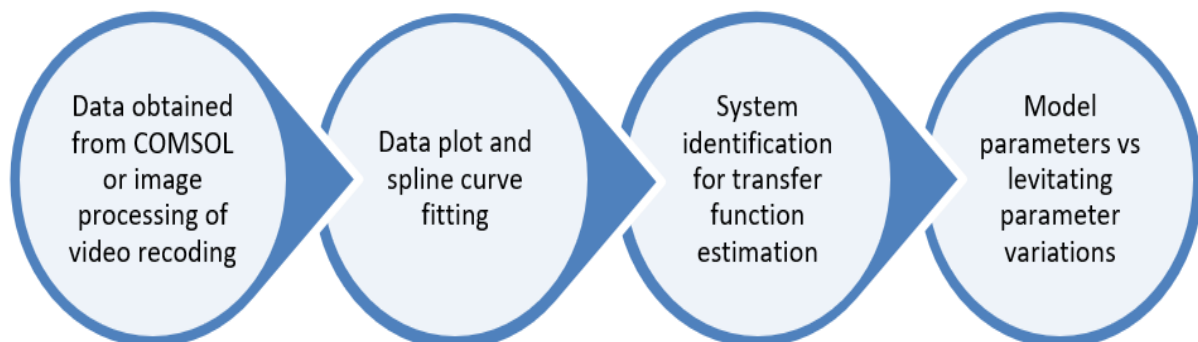
Fig. 3. An example of the particle levitation simulation results obtained from COMSOL software

Figure 4 shows a comparison between numerical and experimental results. The input voltage was 300V. Figure 4(a) is associated with half wavelength distance and Figure 4(b) is related to the wavelength distance between the transducer and the reflector.

According to these Figures, numerical simulation has successfully predicted the particle movement with acceptable accuracy. Both numerical and experimental graphs have the same trends. However, there are more minor oscillations in experimental results. Figure 5 shows the levitated particle movement at successive times in the experiments.



a)



b)

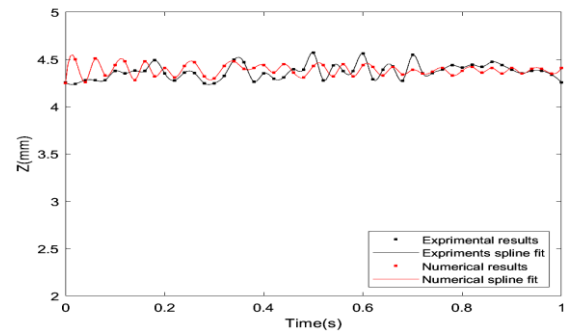


Fig. 4. A comparison study between the numerical and experimental results for the 300v voltage and in (a) $\lambda/2$ and (b) λ distances between the transducer and the reflector



Fig. 5. Movement analysis of the levitated particle in three successive frames of the video recording in the experiments

5. System Identification and Modeling

According to the numerical and experimental results, transient and steady-state motion behaviors can be observed for particles in the levitating space and Modeling control of particles. A dynamical transfer function model for levitation was used to model the particle movement based on the numerical results. The second-order parametric model was selected because of its simplicity for use in different applications, where the (a,b,c,d) are the model $((cs+d)/(s^2+as+b))$ parameters that have been determined and are the Laplace variable. The second-order model assumption could be further justified by the overshoot and damping behavior of particle movements. Figure 6 shows the system identification process and the corresponding results.

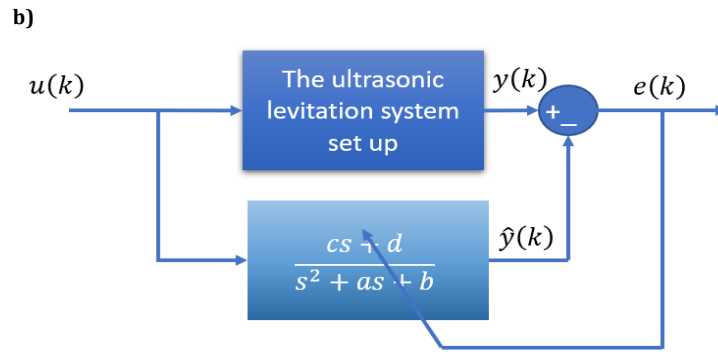


Fig. 6. (a) Data analysis steps, (b) System identification process

Figure 7 shows the effect of the input voltage on the levitated particle movement in a $\lambda/2$ distance between the transducer and the reflector, and Table 1 shows the corresponding model. From this figure, increasing input voltage leads to a decreasing oscillation in particle movement. These phenomena may be coming from increasing input pressure, which results in particles reaching stability in a shorter period. In

addition, this situation occurs in a $3\lambda/2$ gap between the transducer and reflector, as shown in the following figures.

For a better interpretation of the results, the vertical path is shown in Fig. 8(a) and Fig. 8(b) represents the pressure distributions at different input voltages in the half-wavelength distances between the transducer and the reflector.

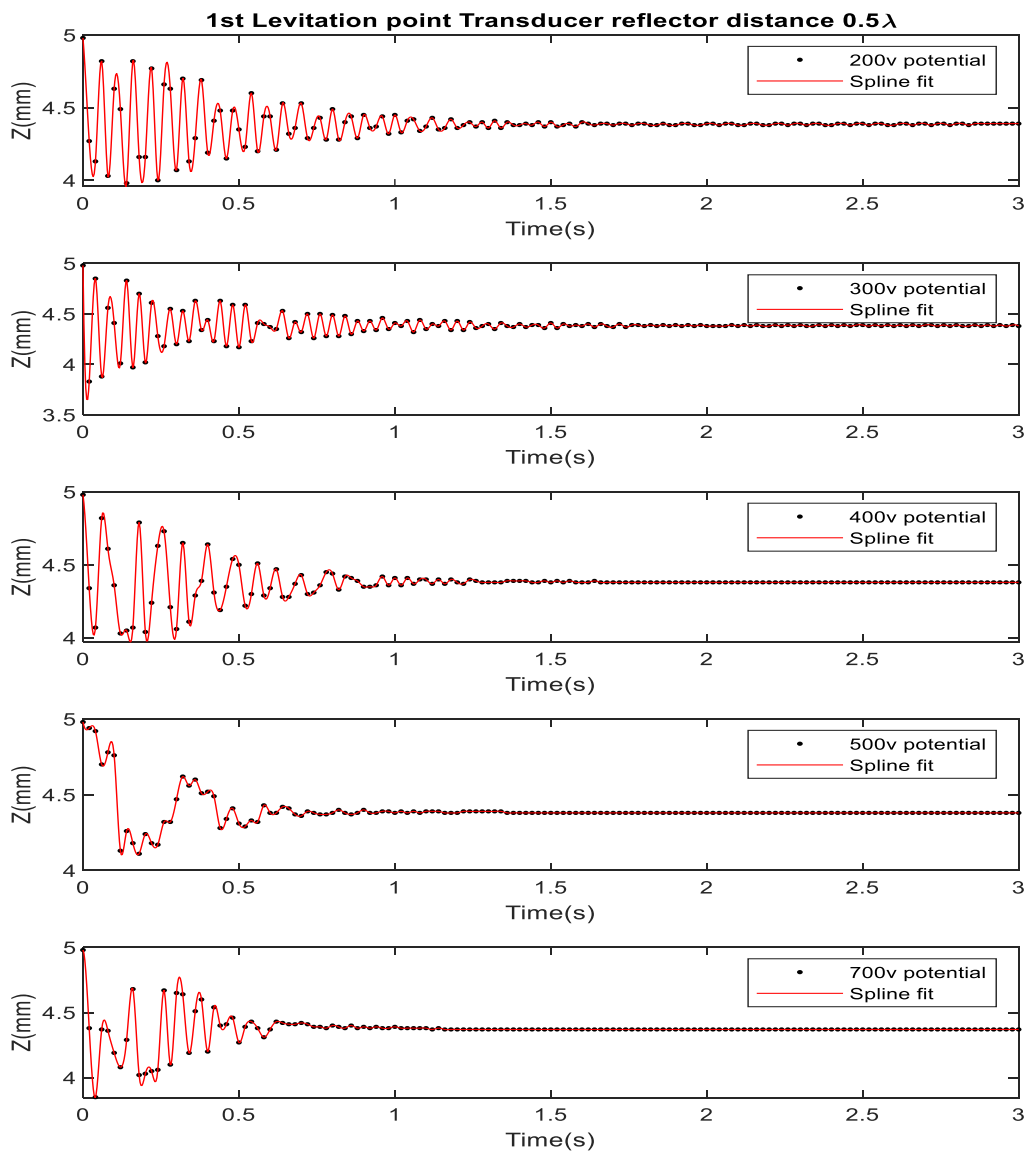
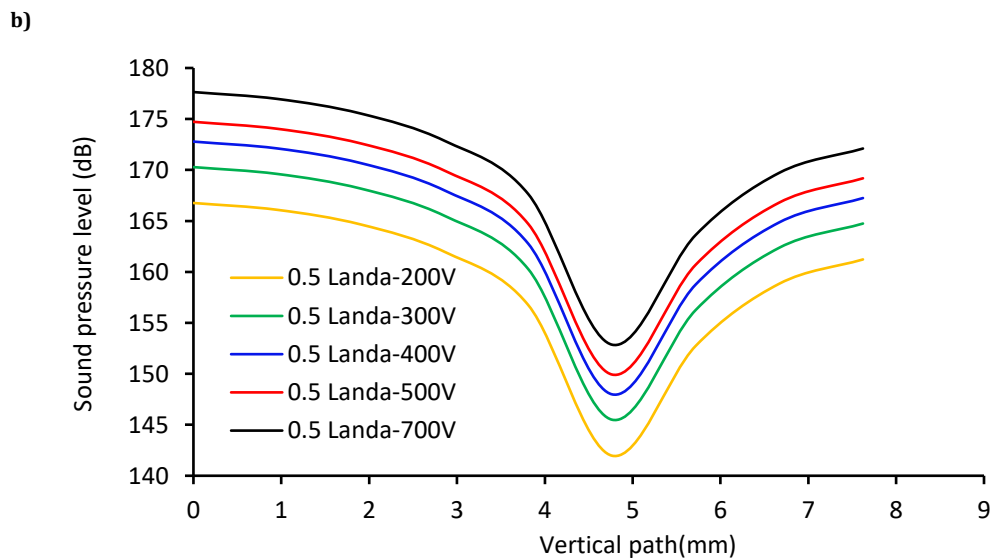
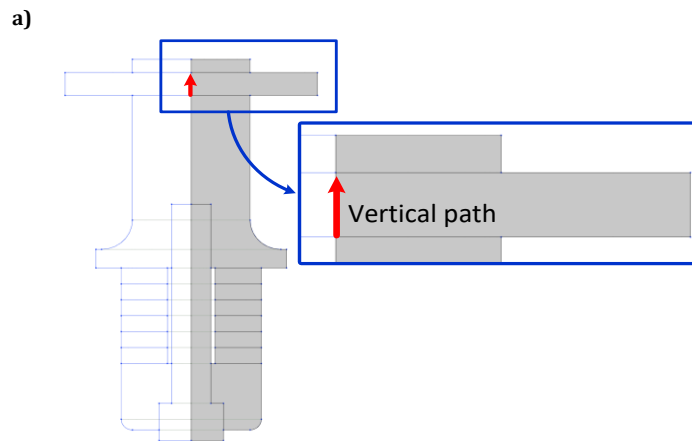


Fig. 7. The particle movement in $\lambda/2$ distance between the transducer and the reflector for selected voltages

Table 1. Model parameters for $\lambda/2$ distance and selected voltage

| Voltage | a | b | c | d | Transfer function |
|---------|----------|----------|----------|---------|-------------------------------|
| 200v | 503.3011 | 702.6611 | -18.6506 | 15.4115 | $\frac{cs + d}{s^2 + as + b}$ |
| 300v | 84.4753 | 114.9861 | 1.2095 | 1.6802 | |
| 400v | 10.5053 | 1.8212 | 0.0601 | 0.0200 | |
| 500v | 20.1498 | 40.9881 | 0.2532 | 0.3588 | |
| 700v | 1.0863 | 0.5498 | 0.0034 | 0.0034 | |


Fig. 8. (a) The vertical path (b) Sound pressure level in $\lambda/2$ distance between the transducer and the reflector for different voltage potentials

A similar trend in the first levitating position at different distances between the transducer and the reflector proves the most stability observed in the highest voltage. Particle movement in the first levitating location in one wavelength between the transducer and the reflector was also studied, and the corresponding model parameters are listed in Table 2.

Particle movement trend and corresponding model parameters for a $3\lambda/2$ distance between

the transducer and the reflector are presented in Table 3, respectively.

Figs. 9 and 10 show the distribution of sound pressure in these situations. It was noticeable from these figures that the best levitating situations in different distances between the transducer and the reflector have a similar sound pressure level. This specific sound pressure level depended upon the mass of a levitated particle.

Table 2. Model parameters for λ distance and selected voltage.

| Voltage | a | b | c | d | Transfer function |
|---------|-----------|-----------|---------|----------|-------------------------------|
| 200V | 1686.3326 | 9694.3332 | 36.8241 | 211.2414 | $\frac{cs + d}{s^2 + as + b}$ |
| 300V | 25.9979 | 22.4519 | -0.1255 | 0.3325 | |
| 400V | 7.4268 | 17.2359 | 0.0537 | 0.1889 | |
| 500V | 473.0081 | 1.6291 | -4.2249 | 0.0207 | |
| 700V | 22.2181 | 84.4719 | 0.0195 | 0.5322 | |

Table 3. Model parameters for $3\lambda/2$ distance and selected voltage

| Voltage | a | b | c | d | Transfer function |
|---------|----------|-----------|---------|----------|-------------------------------|
| 200V | 14.0249 | 6963.8322 | -1.6505 | 152.9568 | $\frac{cs + d}{s^2 + as + b}$ |
| 300V | 39.4131 | 12.0308 | 0.6057 | 0.1753 | |
| 400V | 274.0253 | 165.9903 | 1.9385 | 1.1760 | |
| 500V | 37.6857 | 33.1876 | 0.1784 | 0.2864 | |
| 700V | 53.5574 | 43.8640 | 0.3349 | 0.2750 | |

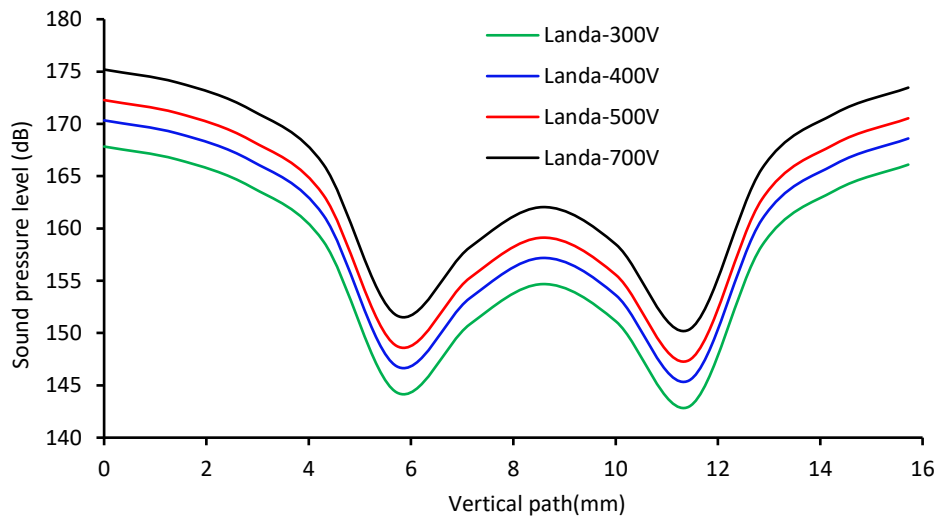


Fig. 9. Sound pressure level in λ distance between the transducer and the reflector for different input voltages

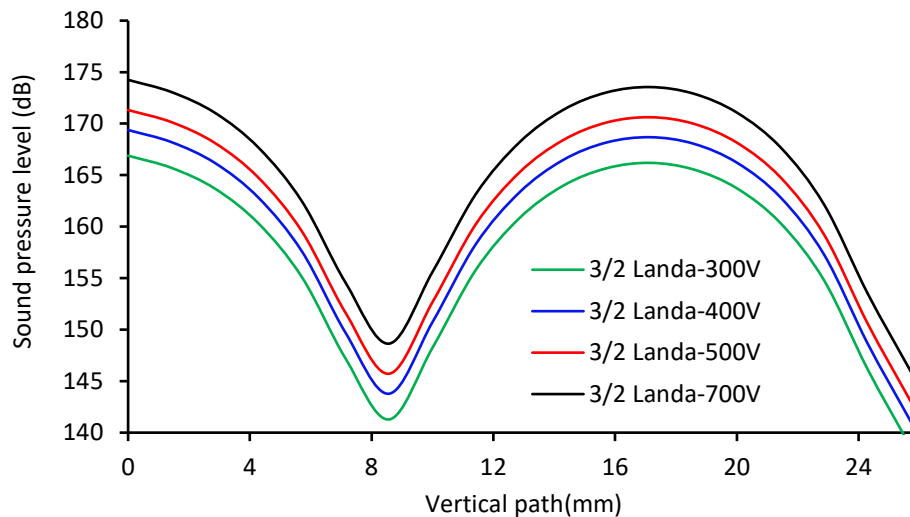


Fig. 10. The sound pressure level in the $3\lambda/2$ gap between the transducer and the reflector for different input voltages

Table 4 shows the effect of the input voltage on the movement of a levitated particle in the second levitating place. The distance between the transducer and the reflector was adjusted to λ . It can be observed that the particle movement trends in the first and second levitating places in a λ wavelength distance between the transducer and the reflector are the same. It can come from a similarity in pressure distribution. The same trend has been seen for a $3\lambda/2$ gap between the transducer and the reflector.

Table 5 shows the trend for a second levitating place in a $3\lambda/2$ distance between the transducer and the reflector. The main difference between the first and second levitating points is the variation between limited voltages in the particle movement trend. Less particle movement of the levitated particle using 700 V

comes from a greater distance between the levitated particle and the transducer.

For the $3\lambda/2$ gap, according to Figure 5, the same procedure existed between the second and third levitating locations.

Figure 11 shows the effect of distances between the transducer and the reflector on particle movement in different input voltages for the first levitating location. From this figure, it was seen that in voltages higher than 500 V, more space between the transducer and the reflector led to less particle movement. It happened because more regular pressure distribution existed in more space between the transducer and the reflector. At low voltages, there is no appropriate input acoustic pressure to follow this routine.

Table 4. Model parameters for λ distance and selected voltages

| Voltage | a | b | c | d | Transfer function |
|---------|-----------|-----------|----------|---------|-------------------------------|
| 200V | 0.0001 | 1.8094 | -40.1871 | 0.1199 | |
| 300V | 2758.1155 | 8401.9226 | 1.4812 | 3.9985 | |
| 400V | 21.4490 | 14.0304 | 0.4765 | 0.4450 | $\frac{cs + d}{s^2 + as + b}$ |
| 500V | 1892.6821 | 116.7319 | -47.9602 | -2.4483 | |
| 700V | 8.2395 | 1.8682 | 0.2623 | 0.0348 | |

Table 5. Model parameters for $3\lambda/2$ distance and selected voltages

| Voltage | a | b | c | d | Transfer function |
|---------|----------|----------|----------|---------|-------------------------------|
| 200V | 503.3011 | 702.6611 | -18.6506 | 15.4115 | |
| 300V | 84.4753 | 114.9861 | 1.2095 | 1.6802 | |
| 400V | 10.5053 | 1.8212 | 0.0601 | 0.0200 | $\frac{cs + d}{s^2 + as + b}$ |
| 500V | 20.1498 | 40.9881 | 0.2532 | 0.3588 | |
| 700V | 1.0863 | 0.5498 | 0.0034 | 0.0034 | |

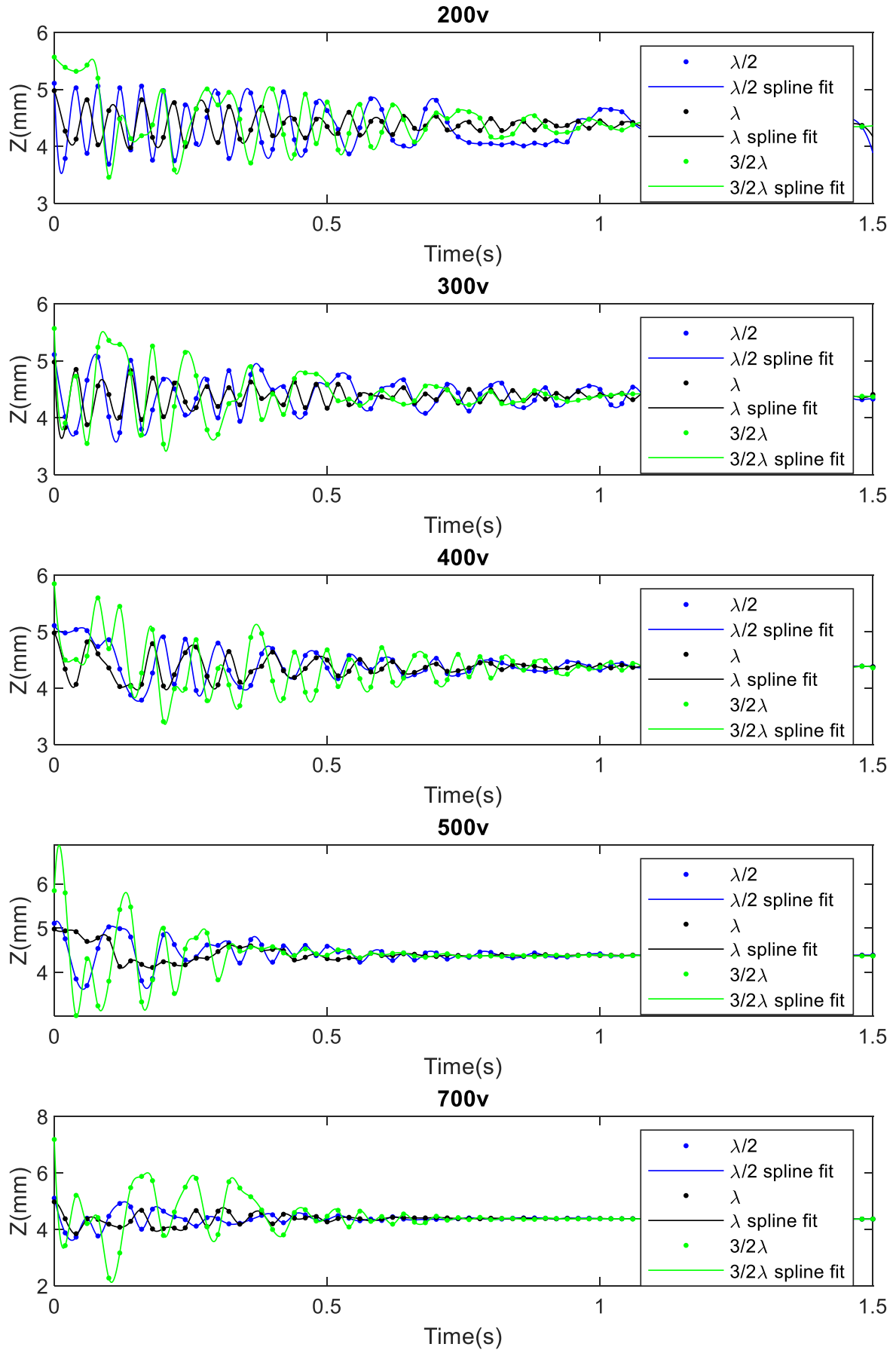


Fig. 11. The particle movement in the first levitating location in different distances between the transducer and the reflector for 200V, 300 V, 400 V, 500 V, and 700V driving voltages

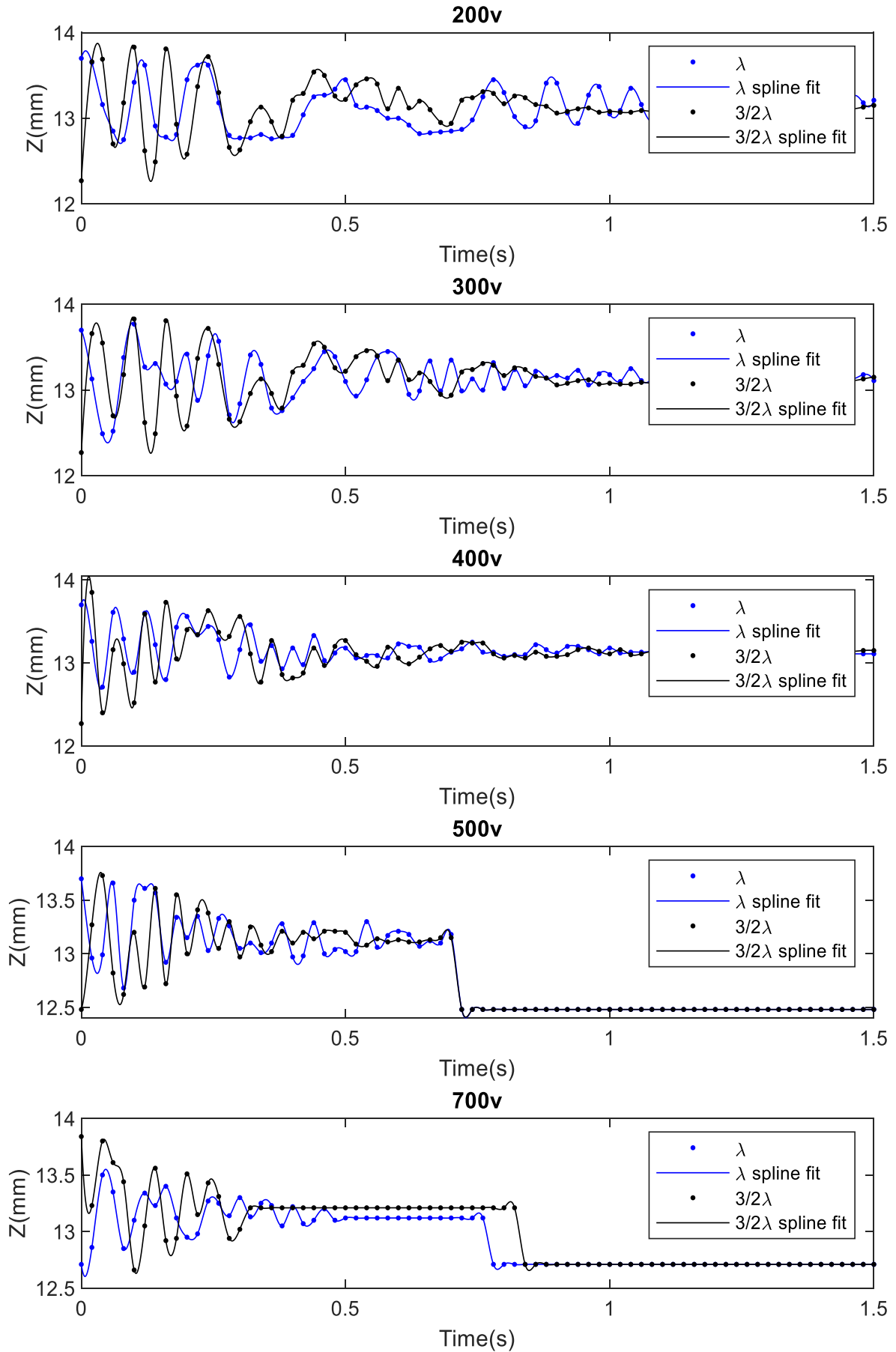


Fig. 12. The particle movement in the second levitating location in different distances between the transducer and the reflector for 200V, 300V, 400V, 500V, and 700V driving voltages

6. Conclusions

A comprehensive model for the levitated particle movement containing the effect of input voltages and the levitated gap in an ultrasonic levitation process is critical in many applications. For this purpose, numerical simulations were performed to predict the movement of levitated particles in an ultrasonic levitator over a range of selected voltage potentials (200V,300V,400V, 500V, and 700V) and distance parameters between the ultrasonic transducer and the reflector ($\lambda/2$, and $3\lambda/2$). Experimental verification of the numerical model shows the reliability of the simulations. A linear model based on the numerical results for the movement of the particles was derived. The model coefficients were presented in different parameters (voltages and gap). The presented model can be used to control and analyze the levitation.

Nomenclature

| | |
|-------------|--|
| w | Gravity |
| F_a | Ultrasonic force |
| F_d | Drag force |
| F_b | Buoyancy force |
| r | Radius |
| ρ | Density |
| U | Radiation potential |
| P_p | Pressure of particle |
| v_p | Particle velocity |
| c | Ultrasound wave |
| c | Sound speed in levitated medium |
| c_s | Sound speed in levitated particle |
| Φ_{in} | Velocity potential of the acoustic field |
| m_p | Particle mass |
| τ_p | Particle response velocity |
| v | Particle velocity |
| u | Denote fluid velocity |
| μ | Fluid viscosity |
| ρ_p | Particle density |
| d_p | Particle diameter |

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Conflicts of Interest

The author declares that there is no conflict of interest regarding the publication of this article.

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